

## LV100 and HV100: High-Voltage Power Modules


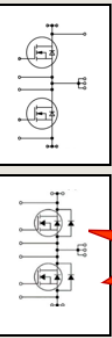
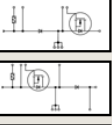
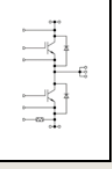


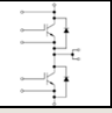
### One Standard. Endless Possibilities.

For high-reliability and demanding applications such as traction and heavy industry, the dual power modules in LV100 and HV100 packages enable robust, high-power-density inverter designs with outstanding reliability and performance. The portfolio covers the key voltage classes ranging from 1700 V up to 4500 V, supporting a wide range of systems. Parallel connection of modules is simplified through optimized terminal positioning and a symmetrical internal package structure, providing maximum design flexibility. For highest efficiency requirements and cutting-edge converter systems, both Full-SiC and Hybrid-SiC technologies are available within the same standardized package enabling a seamless transition toward higher efficiency and increased power density.



#### Product Advantages

- ❑ Availability of Si and SiC technology in same package
- ❑ Power loss reduction by latest generation chipsets
- ❑ Optimized packaging technology with low parasitic inductance and thermal resistance contribute to high energy efficiency and high power density
- ❑ LV100 and HV100 modules have a common package footprint
- ❑ Highest Reliability and Robustness for critical applications
- ❑ Simple, standardized connections allow an optimal system design and easy scalability

Package Type	Circuit Diagram	1700V	3300V	4500V	
<b>LV100</b> $V_{iso} = 6kV$ 	<b>Half-Bridge</b> 		FMF800DC-66BEW <sup>Δ</sup> Unifull™+ <b>800A</b> FMF400DC-66BEW Unifull™+ <b>400A</b> FMF200DC-66BE Unifull™+ <b>200A</b>		
		Full SiC		FMF750DC-66A/-66A-1 <sup>Δ</sup> <b>750A</b> FMF375DC-66A <b>375A</b> FMF185DC-66A <b>185A</b>	
	<b>Chopper</b> 			FMF800E1C-66BEW Unifull™+ <b>800A</b> FMF800E3C-66BEW Unifull™+ <b>800A</b>	
			<b>Half-Bridge</b> 		CMH600DC-66X <sup>Δ</sup> <b>600A</b> CM1200DA-34X <sup>Δ</sup> <b>1200A</b> CM600DA-66X <sup>Δ</sup> <b>600A</b> CM450DA-66X <sup>Δ</sup> <b>450A</b>
	<b>Chopper</b> 			Si	CM600E1A-66X <b>600A</b>
	<b>HV100</b> $V_{iso} = 10.2kV$ 	<b>Half-Bridge</b> 		CM600DE-66X <b>600A</b> CM450DE-66X <b>450A</b>	CM450DE-90X <b>450A</b>

<sup>Δ</sup> Thermistor mounted type

ASIC Baseplate

MCB Baseplate

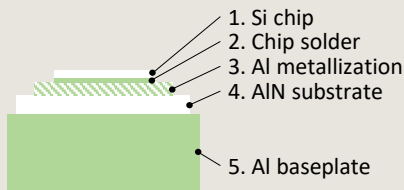
Note: Unifull is trademark of Mitsubishi Electric Corporation

## X-Series Si Modules

The LV100 and HV100 HVIGBT modules use the latest X-Series 7<sup>th</sup>-generation IGBTs with CSTBT technology and RFC diodes delivering enhanced efficiency and robustness. The optimized LNFLR (Linearly-Narrowed Field Limiting Ring) edge termination structure allows an increased active chip area of up to 28 % compared to previous generations, directly contributing to higher current capability and improved power density. The Surface Charge Control (SCC) technology of the chip further enhances the robustness against high humidity.

The standardized LV100 and HV100 package with a footprint of 100 mm x 140 mm allow a simplified design and improved scalability. The terminal layout enables easy parallel connection and a balanced current sharing between the modules, supporting reliable system scaling.

Furthermore, Mitsubishi Electric's high voltage LV100 and HV100 packages use the MCB (Metal Casting Direct Bonding) technology. Compared to conventional packaging structures, these aluminum-based baseplates bond the ceramic substrate directly onto the baseplate, eliminating the need for an additional solder layer resulting in higher thermal conductivity and reduced weight. This enables converter designs with increased output power and higher power density.



MCB-Baseplate Structure

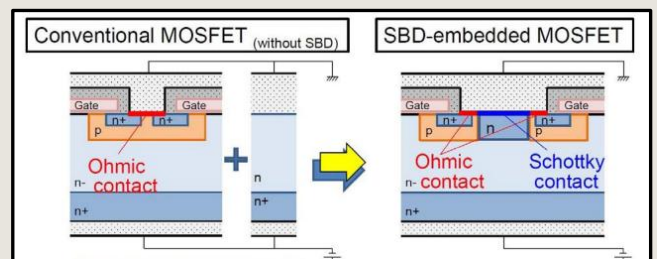


Compared to previous product (CM750HG-130R), the optimized edge termination increases the active chip area by 28 %

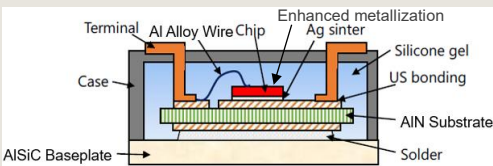
## Unifull™ Plus SiC Modules

The new Unifull™Plus SiC MOSFET modules deliver a superior switching performance through optimized chip design, increased switching speed and reduced switching delay time. A key feature is the integration of an antiparallel Schottky Barrier Diode (SBD) into the MOSFET structure, which suppresses intrinsic body diode conduction. This eliminates the risk of bipolar degradation, a known degradation mechanism that impacts long-term reliability, thereby enhancing overall device robustness.

Optimization of the packaging structure, including the use of sintering technology, Al alloy wire with optimized chip metallization for enhanced power cycling capability, and an AlSiC baseplate for enhanced thermal cycling capability result in a superior overall system performance while achieving a good cycling lifetime. Beyond device-level robustness, extensive reliability testing including gate oxide robustness evaluations as well as HV-H3TRB demonstrate high robustness and long-term stability of the Unifull™Plus family.



Unifull™Plus Concept



Unifull™Plus Package Structure

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